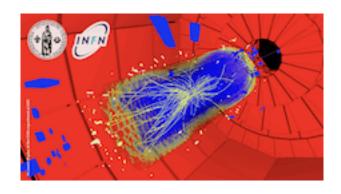
## RD11 - 10th International Conference on Large Scale Applications and Radiation Hardness of Semiconductor Detectors



Wednesday, 6 July 2011 - Friday, 8 July 2011 Sala Convegni della Cassa di Risparmio di Firenze

## **Scientific Programme**

## **Semiconductor Detectors**

**Tracking Systems** 

**Radiation Effects and Hardness** 

**Electronics**